

**Notice of References Cited**

Application/Control No.

09/811,684

Applicant(s)/Patent Under  
Reexamination  
DEMBO ET AL.

Examiner

Harish T Dass

Art Unit

3628

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-5,303,328 A	04-1994	Masui et al.	706/25
*	B	US-6,278,981 B1	08-2001	Dembo et al.	705/36
*	C	US-5,864,857 A	01-1999	Ohata et al.	707/100
*	D	US-5,446,885 A	08-1995	Moore et al.	707/103R
*	E	US-6,078,904 A	06-2000	Rebane, George J.	705/36
	F	US-6,092,056 A	07-2000	Tull et al.	705/36
	G	US-6,317,726 B1	11-2001	O'Shaughnessy, James P.	705/36
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	ProQuest NPL article "Banamex cuts the risk designer-style, Wall Street & Technology, New York; Mar 1994, Zecher, discloses RiskWatch Risk Management OOP.
	V	
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.